Sheet 1 of 2Form PTO-1449
(REV. 1/06)U.S. Dept. of Commerce
PATENT & TRADEMARK OFFICE

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

ATTY DOCKET NO.
106121.03APPLICATION NO.
10/065,264APPLICANT(S)
Masahide TANAKA et al.FILING DATE
September 30, 2002GROUP
2612

U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Name
NDHH	1	5,477,264	12-1995	Sarbadhikari et al.
	2	5,724,579	03-1998	Suzuki, Takeshi
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	4	5,602,458	02-1997	Dowe, David R.
	5	5,875,034	02-1999	Shintani et al.
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NDHH	9	6,580,460 B1	06-2003	Takahashi et al.

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OTHER DOCUMENTS

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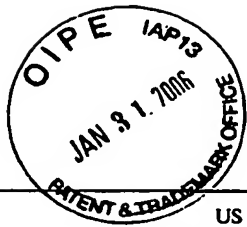
EXAMINER

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Date: January 31, 2006

Sheet 2 of 2

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 106121.03		APPLICATION NO. 10/065,264	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Masahide TANAKA et al.			
				FILING DATE September 30, 2002		GROUP 2612	
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NDHH	19	JP 2005130655 A	05-2005	Japan	X	X	
OTHER DOCUMENTS							
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)					
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